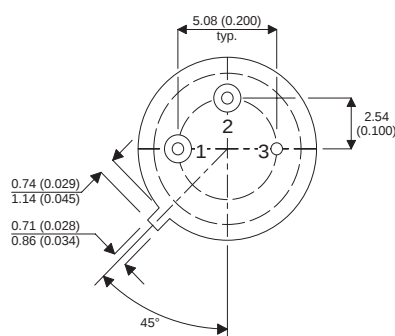
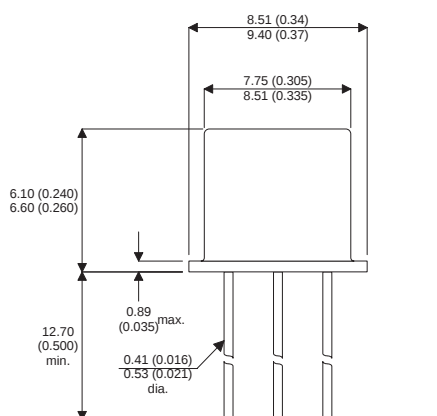


MECHANICAL DATA

Dimensions in mm (inches)



TO-39 METAL (TO205AD)

PIN OUTS

PIN 1 – Emitter PIN 2 – Base PIN 3 – Collector

HIGH VOLTAGE, HIGH CURRENT, HIGH SPEED, NPN SWITCHING TRANSISTOR IN A HERMETICALLY SEALED TO-39 METAL PACKAGE FOR HIGH RELIABILITY APPLICATIONS

FEATURES

- SILICON PLANAR EPITAXIAL NPN TRANSISTOR
- HERMETIC METAL PACKAGE
- CECC SCREENING OPTIONS
- SPACE QUALITY LEVELS OPTIONS
- JAN LEVEL SCREENING OPTIONS
- HIGH SPEED SATURATED SWITCHING

APPLICATIONS:

Hermetically sealed 2N3725 for high reliability applications. Suitable for memory application.

ABSOLUTE MAXIMUM RATINGS ($T_{amb} = 25^{\circ}\text{C}$ unless otherwise stated)

V_{CBO}	Collector-base Voltage ($I_E = 0$)	80V
V_{CES}	Collector-emitter Voltage ($V_{BE} = 0$)	80V
V_{CEO}	Collector-emitter Voltage ($I_B = 0$)	50V
V_{EBO}	Emitter-base Voltage ($I_C = 0$)	6V
I_C	Collector Current	1A
P_{tot}	Total Power Dissipation at $T_{amb} \leq 25^{\circ}\text{C}$ at $T_{case} \leq 25^{\circ}\text{C}$	0.8W 3.5W
T_j	Junction Temperature	– 65 to 200 $^{\circ}\text{C}$
T_{stg}	Storage Temperature	– 65 to 200 $^{\circ}\text{C}$

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ELECTRICAL CHARACTERISTICS ($T_{amb} = 25^{\circ}\text{C}$ unless otherwise stated)

Parameter	Test Conditions	Min.	Typ.	Max.	Unit
I_{CBO} Collector Cutoff Current ($I_E = 0$)	$V_{CB} = 60\text{ V}$			1.7	μA
	$V_{CB} = 60\text{ V}$ $T_{amb} = 100^{\circ}\text{C}$			120	
$V_{(BR)CBO}$ Collector-Base Breakdown Voltage ($I_E = 0$)	$I_C = 10\text{ }\mu\text{A}$	80			V
$V_{(BR)CES}$ Collector-Emitter Breakdown Voltage ($V_{BE} = 0$)	$I_C = 10\text{ }\mu\text{A}$	80			V
$V_{(BR)CEO}^*$ Collector-Emitter Breakdown Voltage ($I_B = 0$)	$I_C = 10\text{ mA}$	50			V
$V_{(BR)EBO}$ Emitter-Base Breakdown Voltage ($I_C = 0$)	$I_E = 10\text{ }\mu\text{A}$	6			V
$V_{CE(sat)}^*$ Collector-Emitter Saturation Voltage	$I_C = 10\text{ mA}$ $I_B = 1\text{ mA}$		0.19	0.25	V
	$I_C = 100\text{ mA}$ $I_B = 10\text{ mA}$		0.21	0.26	
	$I_C = 300\text{ mA}$ $I_B = 30\text{ mA}$		0.31	0.4	
	$I_C = 500\text{ mA}$ $I_B = 50\text{ mA}$		0.4	0.52	
	$I_C = 800\text{ mA}$ $I_B = 80\text{ mA}$		0.5	0.8	
	$I_C = 1000\text{ mA}$ $I_B = 100\text{ mA}$		0.6	0.95	
$V_{BE(sat)}^*$ Base-Emitter Saturation Voltage	$I_C = 10\text{ mA}$ $I_B = 1\text{ mA}$		0.64	0.76	V
	$I_C = 100\text{ mA}$ $I_B = 10\text{ mA}$		0.75	0.86	
	$I_C = 300\text{ mA}$ $I_B = 30\text{ mA}$		0.89	1.1	
	$I_C = 500\text{ mA}$ $I_B = 50\text{ mA}$	0.9		1.2	
	$I_C = 800\text{ mA}$ $I_B = 80\text{ mA}$		1.0	1.5	
	$I_C = 1000\text{ mA}$ $I_B = 100\text{ mA}$		1.1	1.7	
h_{FE}^* DC Current Gain	$I_C = 10\text{ mA}$ $V_{CE} = 1\text{ V}$	30	60		
	$I_C = 100\text{ mA}$ $V_{CE} = 1\text{ V}$	60	90	150	
	$I_C = 300\text{ mA}$ $V_{CE} = 1\text{ V}$	40	60		
	$I_C = 1000\text{ mA}$ $V_{CE} = 5\text{ V}$	25	65		
	$I_C = 800\text{ mA}$ $V_{CE} = 2\text{ V}$	20	40		
	$I_C = 500\text{ mA}$ $V_{CE} = 1\text{ V}$	35			
h_{fe} High Frequency Current Gain ($f = 100\text{Mhz}$)	$I_C = 50\text{ mA}$ $V_{CE} = 10\text{ V}$	3			
C_{CBO} Collector-Base Capacitance ($f = 1\text{Mhz}$)	$I_E = 0$ $V_{CB} = 10\text{ V}$			10	pF
C_{EBO} Emitter-Base Capacitance ($f = 1\text{Mhz}$)	$I_C = 0$ $V_{CB} = 0.5\text{ V}$			55	pF
t_{on} Turn-on Time	$I_C = 500\text{ mA}$ $V_{CC} = 30\text{ V}$ $I_B = 50\text{ mA}$			35	ns
t_{off} Turn off Time	$I_C = 500\text{ mA}$ $V_{CC} = 30\text{ V}$ $I_{B1} = -I_{B2} = 50\text{ mA}$			60	ns

* Pulsed : pulse duration = 300 μs , duty cycle = 1%

THERMAL DATA ($T_{case} = 25^{\circ}\text{C}$ unless otherwise stated)

Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$R_{th\ j-case}$ Thermal Resistance Junction-Case				50	$^{\circ}\text{C/W}$
$R_{th\ j-amb}$ Thermal Resistance Junction-Ambient				220	$^{\circ}\text{C/W}$

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